74LVC2G07

Buffers with open-drain outputs Rev. 7 — 4 July 2012

Product data sheet

General description 1.

The 74LVC2G07 provides two non-inverting buffers.

The output of this device is an open drain and can be connected to other open-drain outputs to implement active-LOW wired-OR or active-HIGH wired-AND functions.

Inputs can be driven from either 3.3 V or 5 V devices. This feature allows the use of this device in a mixed 3.3 V and 5 V environment.

Schmitt trigger action at all inputs makes the circuit tolerant for slower input rise and fall time.

This device is fully specified for partial power-down applications using I_{OFF}. The I_{OFF} circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

Features and benefits 2.

- Wide supply voltage range from 1.65 V to 5.5 V
- 5 V tolerant input/output for interfacing with 5 V logic
- High noise immunity
- Complies with JEDEC standard:
 - ◆ JESD8-7 (1.65 V to 1.95 V)
 - ◆ JESD8-5 (2.3 V to 2.7 V)
 - ◆ JESD8-B/JESD36 (2.7 V to 3.6 V)
- ESD protection:
 - ◆ HBM JESD22-A114F exceeds 2000 V
 - MM JESD22-A115-A exceeds 200 V
- -24 mA output drive ($V_{CC} = 3.0 \text{ V}$)
- CMOS low power consumption
- Latch-up performance exceeds 250 mA
- Direct interface with TTL levels
- Inputs accept voltages up to 5 V
- Multiple package options
- Specified from -40 °C to +85 °C and -40 °C to +125 °C



74LVC2G07

3. Ordering information

Table 1. Ordering information

| Type number | Package | | | | | | | |
|-------------|-------------------|-------|---|---------|--|--|--|--|
| | Temperature range | Name | Description | Version | | | | |
| 74LVC2G07GW | –40 °C to +125 °C | SC-88 | plastic surface-mounted package; 6 leads | SOT363 | | | | |
| 74LVC2G07GV | –40 °C to +125 °C | TSOP6 | plastic surface-mounted package (TSOP6); 6 leads | SOT457 | | | | |
| 74LVC2G07GM | –40 °C to +125 °C | XSON6 | plastic extremely thin small outline package; no leads; 6 terminals; body 1 \times 1.45 \times 0.5 mm | SOT886 | | | | |
| 74LVC2G07GF | –40 °C to +125 °C | XSON6 | plastic extremely thin small outline package; no leads; 6 terminals; body $1 \times 1 \times 0.5$ mm | SOT891 | | | | |
| 74LVC2G07GN | –40 °C to +125 °C | XSON6 | extremely thin small outline package; no leads; 6 terminals; body $0.9 \times 1.0 \times 0.35$ mm | SOT1115 | | | | |
| 74LVC2G07GS | –40 °C to +125 °C | XSON6 | extremely thin small outline package; no leads; 6 terminals; body 1.0 \times 1.0 \times 0.35 mm | SOT1202 | | | | |

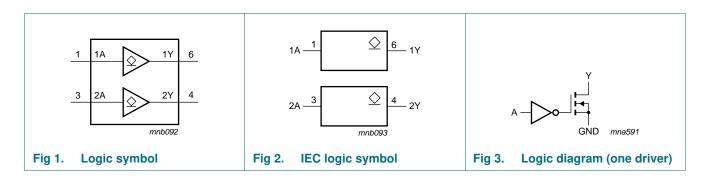
4. Marking

Table 2. Marking

| Type number | Marking code[1] |
|-------------|-----------------|
| 74LVC2G07GW | V7 |
| 74LVC2G07GV | V07 |
| 74LVC2G07GM | V7 |
| 74LVC2G07GF | V7 |
| 74LVC2G07GN | V7 |
| 74LVC2G07GS | V7 |

^[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

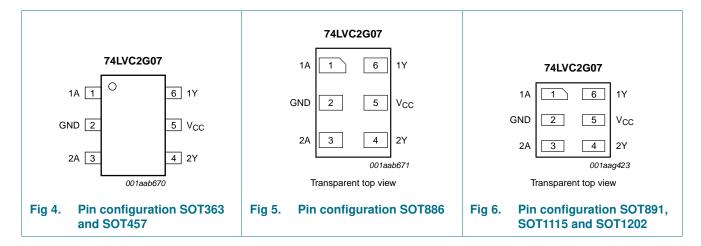
5. Functional diagram



Buffers with open-drain outputs

6. Pinning information

6.1 Pinning



6.2 Pin description

Table 3. Pin description

| Symbol | Pin | Description |
|-----------------|-----|----------------|
| 1A | 1 | data input |
| GND | 2 | ground (0 V) |
| 2A | 3 | data input |
| 2Y | 4 | data output |
| V _{CC} | 5 | supply voltage |
| 1Y | 6 | data output |

7. Functional description

Table 4. Function table[1]

| Input nA | Output nY |
|----------|-----------|
| L | L |
| Н | Z |

^[1] H = HIGH voltage level; L = LOW voltage level; Z = high-impedance OFF-state.

Buffers with open-drain outputs

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------|-------------------------|--|-------------------------------|------|------|
| V_{CC} | supply voltage | | -0.5 | +6.5 | V |
| I _{IK} | input clamping current | $V_I < 0 V$ | -50 | - | mA |
| VI | input voltage | | <u>[1]</u> –0.5 | +6.5 | V |
| I _{OK} | output clamping current | V _O < 0 V | -50 | - | mA |
| Vo | output voltage | Active mode | <u>[1]</u> –0.5 | +6.5 | V |
| | | Power-down mode | [<u>1]</u> [<u>2</u>] –0.5 | +6.5 | V |
| Io | output current | $V_O = 0 V \text{ to } 6.5 V$ | - | 50 | mA |
| I _{CC} | supply current | | - | 100 | mA |
| I_{GND} | ground current | | -100 | - | mA |
| T _{stg} | storage temperature | | -65 | +150 | °C |
| P _{tot} | total power dissipation | $T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$ | <u>[3]</u> _ | 250 | mW |

^[1] The minimum input and output voltage ratings may be exceeded if the input and output current ratings are observed.

9. Recommended operating conditions

Table 6. Recommended operating conditions

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-------------------------------|---------------------|--|------|-----|------|------|
| V_{CC} | supply voltage | | 1.65 | - | 5.5 | V |
| VI | input voltage | | 0 | - | 5.5 | V |
| V _O | output voltage | Active mode | 0 | - | 5.5 | V |
| | | Power-down mode; V _{CC} = 0 V | 0 | - | 5.5 | V |
| T _{amb} | ambient temperature | | -40 | - | +125 | °C |
| Δt/ΔV input transition rise a | | V _{CC} = 1.65 V to 2.7 V | - | - | 20 | ns/V |
| | fall rate | V _{CC} = 2.7 V to 5.5 V | - | - | 10 | ns/V |

^[2] When $V_{CC} = 0 \text{ V}$ (Power-down mode), the output voltage can be 5.5 V in normal operation.

^[3] For SC-88 and SC-74 packages: above 87.5 °C the value of P_{tot} derates linearly with 4.0 mW/K. For XSON6 packages: above 118 °C the value of P_{tot} derates linearly with 7.8 mW/K.

Buffers with open-drain outputs

10. Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

| | , , | , | (0 | , | | | |
|----------------------------------|------------------------------|--|-----|----------------------|------|----------------------|------|
| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
| $T_{amb} = -40$ | °C to +85 °C[1] | | | | | | |
| V_{IH} | HIGH-level input | $V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$ | | $0.65 \times V_{CC}$ | - | - | V |
| | voltage | V _{CC} = 2.3 V to 2.7 V | | 1.7 | - | - | ٧ |
| | | V _{CC} = 2.7 V to 3.6 V | | 2.0 | - | - | ٧ |
| | | V _{CC} = 4.5 V to 5.5 V | | $0.7 \times V_{CC}$ | - | - | ٧ |
| V _{IL} | LOW-level input | $V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$ | | - | - | $0.35 \times V_{CC}$ | ٧ |
| | voltage | V _{CC} = 2.3 V to 2.7 V | | - | - | 0.7 | ٧ |
| | | V _{CC} = 2.7 V to 3.6 V | | - | - | 0.8 | ٧ |
| | | V _{CC} = 4.5 V to 5.5 V | | - | - | $0.3 \times V_{CC}$ | ٧ |
| V _{OL} LOW-level output | | $V_I = V_{IH}$ or V_{IL} | | | | | |
| voltage | voltage | $I_O = 100 \ \mu A$; $V_{CC} = 1.65 \ V$ to 5.5 V | | - | - | 0.10 | ٧ |
| | | I _O = 4 mA; V _{CC} = 1.65 V | | - | - | 0.45 | ٧ |
| | | $I_{O} = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$ | | - | - | 0.30 | ٧ |
| | | $I_O = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$ | | - | - | 0.40 | ٧ |
| | | $I_O = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$ | | - | - | 0.55 | ٧ |
| | | $I_{O} = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$ | | - | - | 0.55 | ٧ |
| I _I | input leakage current | $V_1 = 5.5 \text{ V or GND};$ $V_{CC} = 0 \text{ V to } 5.5 \text{ V}$ | [2] | - | ±0.1 | ±5 | μΑ |
| l _{OZ} | OFF-state output current | $V_I = V_{IH}$ or V_{IL} ; $V_O = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$ | | - | ±0.1 | ±10 | μΑ |
| I _{OFF} | power-off leakage current | $V_{I} \text{ or } V_{O} = 5.5 \text{ V}; V_{CC} = 0 \text{ V}$ | | - | ±0.1 | ±10 | μΑ |
| I _{CC} | supply current | $V_{I} = 5.5 \text{ V or GND}; I_{O} = 0 \text{ A};$ $V_{CC} = 1.65 \text{ V to } 5.5 \text{ V}$ | | - | 0.1 | 10 | μΑ |
| Δl _{CC} | additional supply current | per pin; $V_I = V_{CC} - 0.6 \text{ V}; I_O = 0 \text{ A};$ $V_{CC} = 2.3 \text{ V to } 5.5 \text{ V}$ | [2] | - | 5 | 500 | μΑ |
| Cı | input capacitance | | | - | 2.5 | - | pF |
| | | | | | | | |

Buffers with open-drain outputs

 Table 7.
 Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-------------------------------------|------------------------------|---|----------------------|-----|----------------------|------|
| T _{amb} = -40 | °C to +125 °C | | | | | |
| V_{IH} | HIGH-level input | V _{CC} = 1.65 V to 1.95 V | $0.65 \times V_{CC}$ | - | - | ٧ |
| | voltage | V _{CC} = 2.3 V to 2.7 V | 1.7 | - | - | ٧ |
| | | V _{CC} = 2.7 V to 3.6 V | 2.0 | - | - | ٧ |
| | | V _{CC} = 4.5 V to 5.5 V | $0.7 \times V_{CC}$ | - | - | ٧ |
| V _{IL} | LOW-level input | V _{CC} = 1.65 V to 1.95 V | - | - | $0.35 \times V_{CC}$ | ٧ |
| | voltage | V _{CC} = 2.3 V to 2.7 V | - | - | 0.7 | ٧ |
| | | V _{CC} = 2.7 V to 3.6 V | - | - | 8.0 | ٧ |
| | | V _{CC} = 4.5 V to 5.5 V | - | - | $0.3 \times V_{CC}$ | ٧ |
| V _{OL} LOW-level o voltage | LOW-level output | $V_I = V_{IH}$ or V_{IL} | | | | |
| | voltage | I_{O} = 100 μ A; V_{CC} = 1.65 V to 5.5 V | - | - | 0.10 | ٧ |
| | | $I_O = 4 \text{ mA}; V_{CC} = 1.65 \text{ V}$ | - | - | 0.70 | ٧ |
| | | $I_{O} = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$ | - | - | 0.45 | ٧ |
| | | $I_{O} = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$ | - | - | 0.60 | ٧ |
| | | $I_{O} = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$ | - | - | 0.80 | ٧ |
| | | $I_{O} = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$ | - | - | 0.80 | ٧ |
| I _I | input leakage current | $V_1 = 5.5 \text{ V or GND};$ $V_{CC} = 0 \text{ V to } 5.5 \text{ V}$ | - | - | ±20 | μΑ |
| l _{OZ} | OFF-state output current | $V_{I} = V_{IH}$ or V_{IL} ; $V_{O} = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$ | - | - | ±10 | μА |
| I _{OFF} | power-off leakage current | V_I or $V_O = 5.5 \text{ V}$; $V_{CC} = 0 \text{ V}$ | - | - | ±20 | μА |
| I _{CC} | supply current | $V_I = 5.5 \text{ V or GND; } I_O = 0 \text{ A;}$ $V_{CC} = 1.65 \text{ V to } 5.5 \text{ V}$ | - | - | 40 | μА |
| Δl _{CC} | additional supply current | per pin; $V_I = V_{CC} - 0.6 \text{ V}$; $I_O = 0 \text{ A}$; $V_{CC} = 2.3 \text{ V}$ to 5.5 V | - | - | 5000 | μА |

^[1] All typical values are measured at T_{amb} = 25 °C.

^[2] These typical values are measured at V_{CC} = 3.3 V.

11. Dynamic characteristics

Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). For test circuit see Figure 8.

| Symbol | Parameter | Conditions | | -40 °C to +85 °C | | | -40 °C to +125 °C | | Unit |
|----------|--|--|-----|------------------|--------|-----|-------------------|-----|------|
| | | | | Min | Typ[1] | Max | Min | Max | |
| t_{pd} | propagation delay | nA to nY; see Figure 7 | [2] | | | | | | |
| | $V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$ | | 1.0 | 3.5 | 6.7 | 1.0 | 8.4 | ns | |
| | | $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$ | | 0.5 | 2.4 | 4.3 | 0.5 | 5.5 | ns |
| | V _{CC} = 2.7 V | | 1.0 | 2.3 | 4.2 | 1.0 | 5.3 | ns | |
| | | $V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$ | | 0.5 | 2.6 | 3.7 | 0.5 | 4.7 | ns |
| | | $V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$ | | 0.5 | 1.5 | 2.9 | 0.5 | 3.7 | ns |
| C_{PD} | power dissipation capacitance | $V_I = GND \text{ to } V_{CC}; V_{CC} = 3.3 \text{ V}$ | [3] | - | 6.5 | - | - | - | pF |

^[1] Typical values are measured at $T_{amb} = 25$ °C and $V_{CC} = 1.8$ V, 2.5 V, 2.7 V, 3.3 V and 5.0 V respectively.

[3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum (C_L \times V_{CC}^2 \times f_o)$$
 where:

 f_i = input frequency in MHz;

fo = output frequency in MHz;

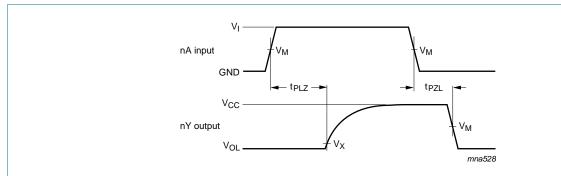
C_L = output load capacitance in pF;

 V_{CC} = supply voltage in V;

N = number of inputs switching;

 $\sum (C_L \times V_{CC}^2 \times f_o) = sum \text{ of outputs.}$

12. Waveforms



Measurement points are given in Table 9.

V_{OL} is the typical output voltage drop that occur with the output load.

Fig 7. The input (nA) to output (nY) propagation delays

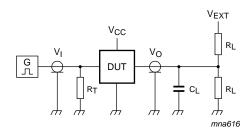
^[2] t_{pd} is the same as t_{PLZ} and t_{PZL} .

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Table 9. **Measurement points**

| Supply voltage | Input | Output | | | |
|------------------|---------------------|---------------------|--------------------------|--|--|
| V _{CC} | V _M | V _M | V _X | | |
| 1.65 V to 1.95 V | $0.5 \times V_{CC}$ | $0.5 \times V_{CC}$ | V _{OL} + 0.15 V | | |
| 2.3 V to 2.7 V | $0.5 \times V_{CC}$ | $0.5 \times V_{CC}$ | V _{OL} + 0.15 V | | |
| 2.7 V | 1.5 V | 1.5 V | V _{OL} + 0.3 V | | |
| 3.0 V to 3.6 V | 1.5 V | 1.5 V | V _{OL} + 0.3 V | | |
| 4.5 V to 5.5 V | $0.5 \times V_{CC}$ | $0.5 \times V_{CC}$ | V _{OL} + 0.3 V | | |



Test data is given in Table 10.

Definitions for test circuit:

 R_L = Load resistance.

 C_L = Load capacitance including jig and probe capacitance.

 R_T = Termination resistance should be equal to the output impedance Z_0 of the pulse generator.

 V_{EXT} = External voltage for measuring switching times.

Test circuit for measuring switching times Fig 8.

Table 10. Test data

| Supply voltage | Input | | Load | | V _{EXT} |
|------------------|-----------------|---------------------------------|----------------|----------------|-------------------------------------|
| V _{CC} | VI | t _r , t _f | C _L | R _L | t _{PZL} , t _{PLZ} |
| 1.65 V to 1.95 V | V _{CC} | ≤ 2.0 ns | 30 pF | 1 kΩ | $2\times V_{CC}$ |
| 2.3 V to 2.7 V | V _{CC} | ≤ 2.0 ns | 30 pF | 500 Ω | $2\times V_{CC}$ |
| 2.7 V | 2.7 V | ≤ 2.5 ns | 50 pF | 500 Ω | 6 V |
| 3.0 V to 3.6 V | 2.7 V | ≤ 2.5 ns | 50 pF | 500 Ω | 6 V |
| 4.5 V to 5.5 V | V _{CC} | ≤ 2.5 ns | 50 pF | 500 Ω | $2\times V_{CC}$ |

13. Package outline

Plastic surface-mounted package; 6 leads

SOT363

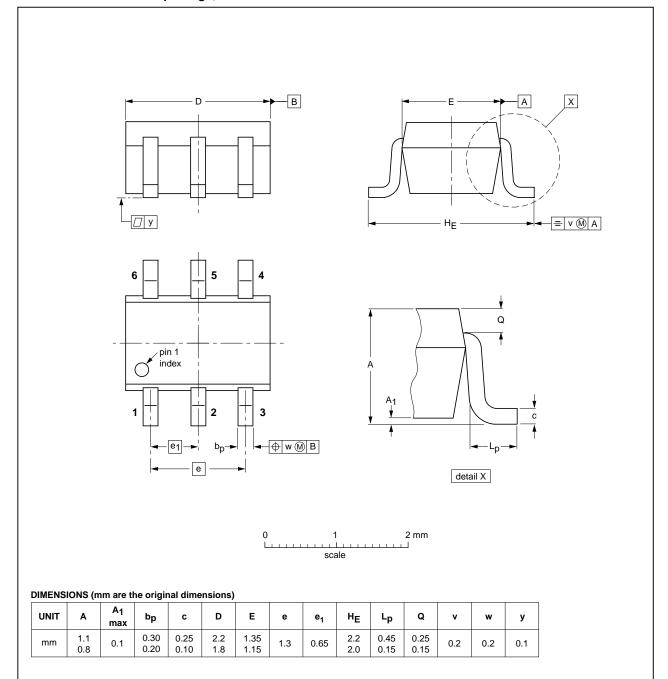


Fig 9. Package outline SOT363 (SC-88)

IEC

JEDEC

ISSUE DATE

04-11-08

06-03-16

EUROPEAN

PROJECTION

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OUTLINE

VERSION

SOT363

JEITA

SC-88

REFERENCES

Plastic surface-mounted package (TSOP6); 6 leads

SOT457

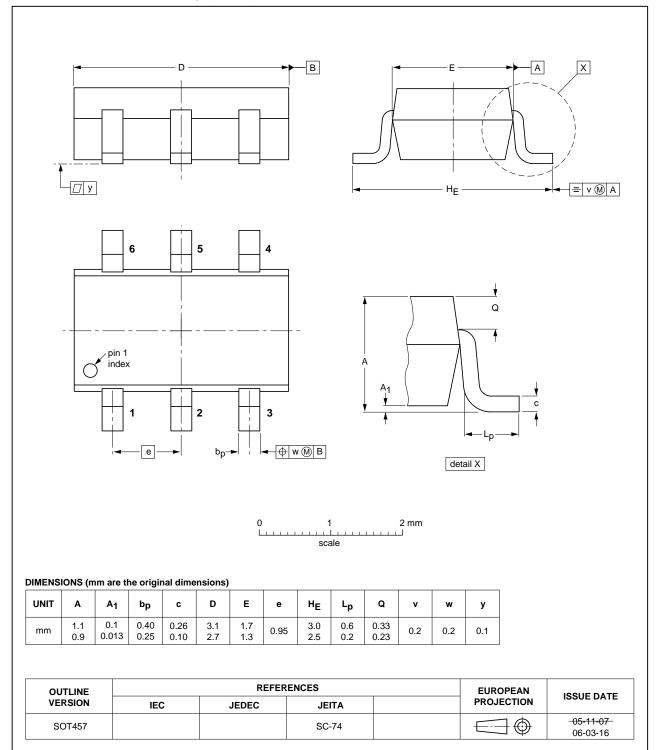


Fig 10. Package outline SOT457 (TSOP6)

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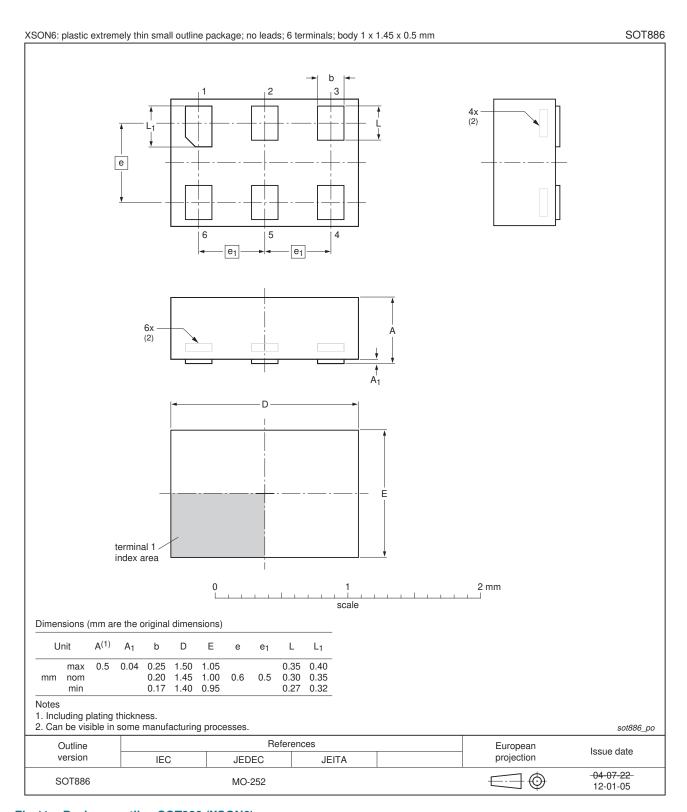


Fig 11. Package outline SOT886 (XSON6)

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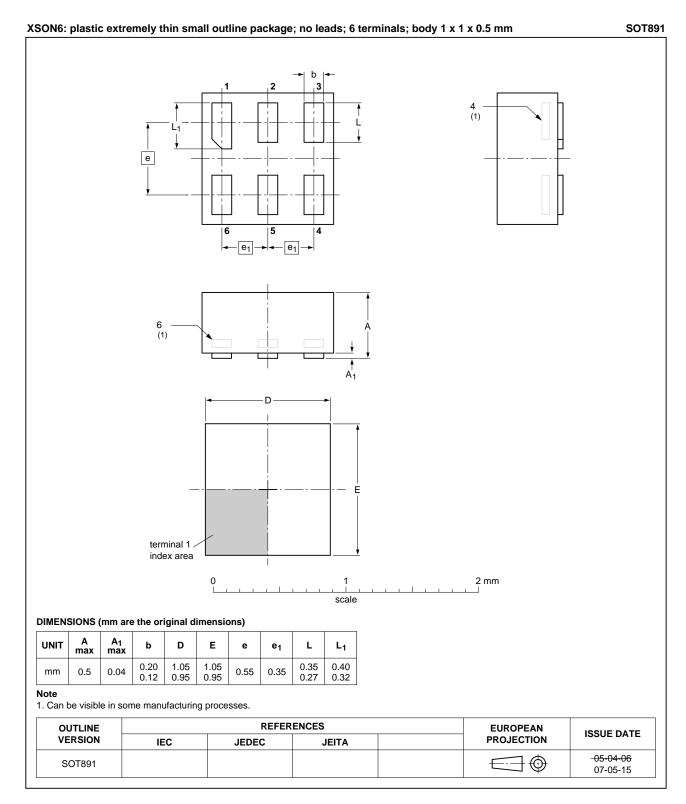


Fig 12. Package outline SOT891 (XSON6)

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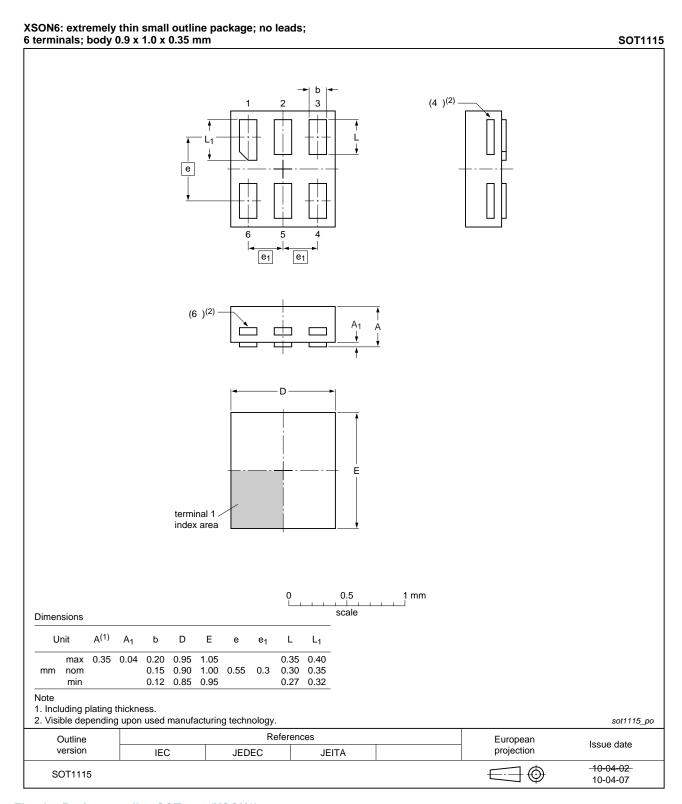


Fig 13. Package outline SOT1115 (XSON6)

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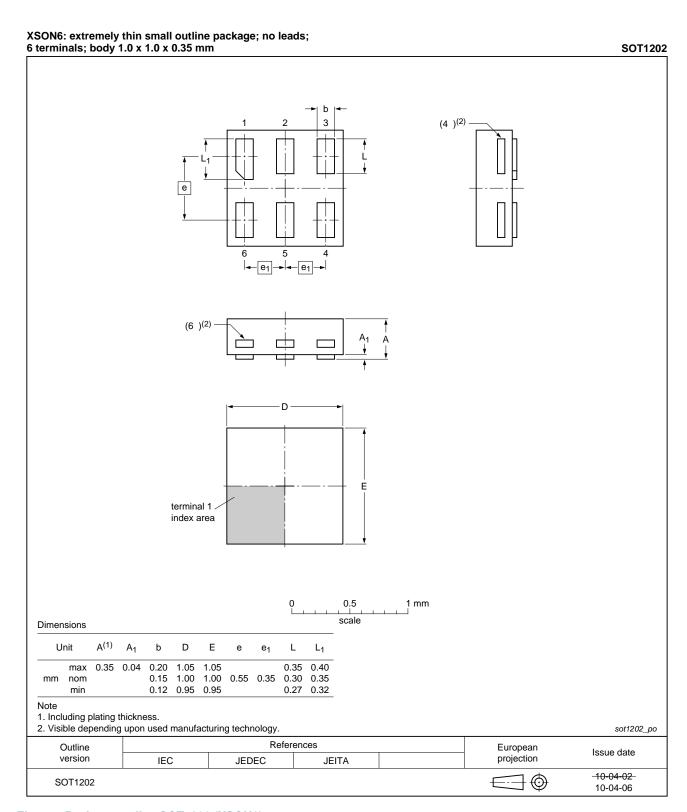


Fig 14. Package outline SOT1202 (XSON6)

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Buffers with open-drain outputs

14. Abbreviations

Table 11. Abbreviations

| Acronym | Description |
|---------|---|
| CMOS | Complementary Metal Oxide Semiconductor |
| DUT | Device Under Test |
| ESD | ElectroStatic Discharge |
| НВМ | Human Body Model |
| MM | Machine Model |
| TTL | Transistor-Transistor Logic |

15. Revision history

Table 12. Revision history

| | - | | | | |
|----------------|---------------------------------|-------------------------------------|---------------------|---------------|--|
| Document ID | Release date | Data sheet status | Change notice | Supersedes | |
| 74LVC2G07 v.7 | 20120704 | Product data sheet | - | 74LVC2G07 v.6 | |
| Modifications: | Package ou | ıtline drawing of SOT886 (<u>F</u> | igure 11) modified. | | |
| 74LVC2G07 v.6 | 20111130 | Product data sheet | - | 74LVC2G07 v.5 | |
| Modifications: | Legal pages | Legal pages updated. | | | |
| 74LVC2G07 v.5 | 20100806 | Product data sheet | - | 74LVC2G07 v.4 | |
| 74LVC2G07 v.4 | 20070521 | Product data sheet | - | 74LVC2G07 v.3 | |
| 74LVC2G07 v.3 | 20040908 | Product data sheet | - | 74LVC2G07 v.2 | |
| 74LVC2G07 v.2 | 20040319 | Product data sheet | - | 74LVC2G07 v.1 | |
| 74LVC2G07 v.1 | 20030825 | Product data sheet | - | - | |
| | | | | | |

16. Legal information

16.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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